## 18V Input, 4A, $\mathrm{ACOT}^{\circledR}$ Buck Converter with Both FETs OC Protection

## General Description

The RT6264A/B is a simple, easy-to-use, 4 A synchronous step-down DC-DC converter with an input supply voltage range of 4.5 V to 18 V . The device possesses an accurate 0.765 V reference voltage and integrates low RdS(ON) power MOSFETs to achieve high efficiency.
The RT6264A/B adopts Advanced Constant On-Time (ACOT ${ }^{\circledR}$ ) control architecture to provide an ultrafast transient response with few external components and to operate in nearly constant switching frequency over the line, load, and output voltage range. The RT6264A operates in automatic PSM that maintains high efficiency during light load operation. The RT6264B operates in Forced PWM that helps meet tight voltage regulation accuracy requirements.
The RT6264A/B senses both FETs current for a robust over-current protection. The device features cycle-by-cycle current limit protection to prevent the device from the catastrophic damage in output short circuit, over-current or inductor saturation conditions. A built-in soft-start function prevents inrush current during start-up. The device also includes input under-voltage lockout, output under-voltage protection, and over-temperature protection (thermal shutdown) to provide safe and smooth operation in all operating conditions.

The recommended junction temperature range is $-40^{\circ} \mathrm{C}$ to $125^{\circ} \mathrm{C}$.

## Features

- 4A Converter Integrated $66 \mathrm{~m} \Omega$ and $36 \mathrm{~m} \Omega$ FETs
- Input Supply Voltage Range : 4.5V to 18 V
- Output Voltage Range : 0.765V to 7V
- Advanced Constant On-Time (ACOT ${ }^{\circledR}$ ) Control
- Ultrafast Transient Response
- Optimized for Low-ESR Ceramic Output Capacitors
- High Accuracy Feedback Reference Voltage : Typ. $\pm 1 \%$
- Optional for Operation Modes :
- RT6264A : Power Saving Mode (PSM)
- RT6264B : Forced PWM Mode
- Fixed Switching Frequency : 650kHz
- Enable Control and Internally Fixed Soft-Start with typ. 1ms
- Input Under-Voltage Lockout (UVLO)
- Protection Function
- Output Under-Voltage Protection (UVP) with Hiccup Mode
- High- / Low-side MOSFET OCP and OTP Function
- RoHS Compliant and Halogen Free


## Simplified Application Circuit



## Ordering Information

RT6264A/B $\square \square \square$
Package Type
J6F: TSOT-23-6 (FC)
Lead Plating System
G: Richtek Green Policy Complia
UVP Option
H: Hiccup
PWM Operation Mode
A: Automatic PSM
B: Forced PWM

Note:
Richtek products are Richtek Green Policy compliant and compatible with the current requirements of IPC/JEDEC J-STD-020

## Marking Information

RT6264AHGJ6F
$3 \mathrm{~A}=\mathrm{DNN}$

3A=: Product Code
DNN : Date Code

RT6264BHGJ6F
$39=\mathrm{DNN}$

39= : Product Code
DNN : Date Code

## Applications

- Set-Top Boxes
- LCD TVs
- Home Networking Devices
- Surveillance
- General Purpose


## Pin Configuration

(TOP VIEW)


TSOT-23-6 (FC)

## Functional Pin Description

| Pin No. | Pin Name | Pin Function |
| :---: | :--- | :--- |
| 1 | GND | Power ground. |
| 2 | SW | Switch node between the internal switch and the synchronous rectifier. <br> Connect this pin to the inductor and bootstrap capacitor. |
| 3 | VIN | Power input. The input voltage range is from 4.5V to 18V. Connect input <br> bypass capacitors directly to this pin and GND pins. The MLCC with <br> capacitance higher than 20 FF is recommended. |
| 4 | FB | Feedback voltage input. Connect this pin to the midpoint of the external <br> feedback resistive divider to set the output voltage of the converter to the <br> desired regulation level. The device regulates the FB voltage at feedback <br> reference voltage, typically 0.765 V. |
| 5 | EN | Enable control input. Connect this pin to logic high enables the device and <br> connect this pin to GND disables the device. |
| 6 | BOOT | Bootstrap capacitor connection node to supply the high-side gate driver. <br> Connect a $0.1 \mu \mathrm{~F}$ ceramic capacitor between this pin and the SW pin. |

## Functional Block Diagram



## Operation

The RT6264A/B is a high-efficiency, synchronous step-down DC-DC converter that can deliver up to 4A output current from a 4.5 V to 18 V input supply.

## Advanced Constant On-Time Control and PWM

 OperationThe RT6264A/B adopts ACOT ${ }^{\circledR}$ control for its ultrafast transient response, low external component counts and stable with low ESR MLCC output capacitors. When the feedback voltage falls below the feedback reference voltage, the minimum off-time one-shot (200ns, typ.) has timed out and the inductor current is below the current limit threshold, then the internal on-time one-shot circuitry is triggered and the high-side switch is turn-on. Since the minimum off-time is short, the device exhibits ultrafast transient response and enables the use of smaller output capacitance.

The on-time is inversely proportional to input voltage and directly proportional to output voltage to achieve pseudo-fixed frequency over the input voltage range. After the on-time one-shot timer expired, the high-side switch is turned off and the low-side switch is turned on until the on-time one-shot is triggered again. To achieve stable operation with low-ESR ceramic output capacitors, an internal ramp signal is added to the feedback reference voltage to simulate the output voltage ripple.

## Power Saving Mode (RT6264A Only)

The RT6264A automatically enters power saving mode (PSM) at light load to maintain high efficiency. As the load current decreases, the inductor current ripple valley eventually touches the zero current, which is the boundary between continuous conduction and discontinuous conduction modes. The low-side switch is turned off when the zero inductor current is detected. In this case, the output capacitor is only discharged by load current so that the switching frequency decreases. As the result, the light-load efficiency can be enhanced due to lower switching loss.

## Enable Control

The RT6264A/B provides an EN pin, as an external chip enable control, to enable or disable the device. If

VEN is held below a logic-low threshold voltage (VEN_L) of the enable input (EN), the converter will disable output voltage, that is, the converter is disabled and switching is inhibited even if the VIN voltage is above VIN under-voltage lockout threshold (VuVLO). During shutdown mode, the supply current can be reduced to ISHDN ( $10 \mu \mathrm{~A}$ or below). If the EN voltage rises above the logic-high threshold voltage (VEN_H) while the VIN voltage is higher than UVLO threshold, the device will be turned on, that is, switching being enabled and soft-start sequence being initiated. An internal resistor Ren_dN from EN to GND allows EN float to shutdown the chip.

## Soft-Start (SS)

The RT6264A/B provides an internal soft-start feature for inrush control. At power up, the internal capacitor is charged by an internal current source to generate a soft-start ramp voltage as a reference voltage to the PWM comparator. The device will initiate switching and the output voltage will smoothly ramp up to its targeted regulation voltage only after this ramp voltage is greater than the feedback voltage VFB to ensure the converters have a smooth start-up from pre-biased output. The output voltage starts to rise in 0.3 ms from EN rising, and the soft-start ramp-up time (VFB from OV to 0.765 V ) is 1 ms .


## Input Under-Voltage Lockout

In addition to the EN pin, the RT6264A/B also provides enable control through the VIN pin. It features an under-voltage lockout (UVLO) function that monitors the internal linear regulator (VCC). If VEN rises above VEN_H first, switching will still be inhibited until the VIN voltage rises above VuvLo. It is to ensure that the
internal regulator is ready so that operation with not-fully-enhanced internal MOSFET switches can be prevented. After the device is powered up, if the input voltage VIN goes below the UVLO falling threshold voltage (VUVLO - $\Delta$ VUVLO), this switching will be inhibited; if VIN rises above the UVLO rising threshold (VUVLO), the device will resume normal operation with a complete soft-start.

## Output Under-Voltage Protection and Hiccup Mode

The RT6264A/B includes output under-voltage protection (UVP) against over-load or short-circuited condition by constantly monitoring the feedback voltage $\mathrm{V}_{\mathrm{FB}}$. If $\mathrm{V}_{\mathrm{FB}}$ drops below the under-voltage protection trip threshold (typically $65 \%$ of the internal feedback reference voltage), the UV comparator will go high to turn off both the internal high-side and low-side MOSFET switches.
If the output under-voltage condition continues for a period of time, the RT6264A/B will enter output under-voltage protection with hiccup mode. During hiccup mode, the IC will shut down for thicCUP_OFF (15ms), and then attempt to recover automatically for thICCUP_ON ( 1.8 ms ). Upon completion of the soft-start sequence, if the fault condition is removed, the converter will resume normal operation; otherwise, such cycle for auto-recovery will be repeated until the fault condition is cleared. The hiccup mode allows the circuit to operate safely with low input current and power dissipation, and then the converter resumes normal operation as soon as the over-load or short-circuit condition is removed.


## The Over-Current Protection

The RT6264A/B features cycle-by-cycle current-limit protection on both the high-side and low-side MOSFETs and prevents the device from the catastrophic damage in output short-circuit, over-current or inductor saturation conditions.

The high-side MOSFET over-current protection is achieved by an internal current comparator that monitors the current in the high-side MOSFET during each on-time. The switch current is compared with the high-side switch peak-current limit (LLIM_H) after a certain amount of delay when the high-side switch being turned on each cycle. If an over-current condition occurs, the converter will immediately turns off the high-side switch and turns on the low-side switch to prevent the inductor current exceeding the high-side current limit.

The low-side MOSFET over-current protection is achieved by measuring the inductor current through the synchronous rectifier (low-side switch) during the low-side on-time. Once the current rises above the low-side switch valley current limit (ILIM_L), the on-time one-shot will be inhibited until the inductor current ramps down to the current limit level (ILIM_L), that is, another on-time can only be triggered when the inductor current goes below the low-side current limit. If the output load current exceeds the available inductor current (clamped by the low-side current limit), the output capacitor needs to supply the extra current such that the output voltage will begin to drop. If it drops below the output under-voltage protection trip threshold, the IC will stop switching to avoid excessive heat.

## Negative Over-Current Limit

The RT6264B is the part which is forced to PWM and allows negative current operation.
In case of PWM operation, high negative current may be generated as an external power source is tied to output terminal unexpectedly. As the risk described above, the internal circuit monitors negative current in each on-time interval of low-side MOSFET and compares it with NOC threshold.
Once the negative current exceeds the NOC threshold, the low-side MOSFET is turned off immediately, and then the high-side MOSFET will be turned on to
discharge the energy of output inductor. This behavior can keep the valley of negative current at NOC threshold to protect low-side MOSFET. However, the negative current can't be limited at NOC threshold anymore since minimum off-time is reached.

## Thermal Shutdown

The RT6264A/B includes an over-temperature protection (OTP) circuitry to prevent overheating due to excessive power dissipation. The OTP will shut down switching operation when junction temperature exceeds a thermal shutdown threshold (TsD). Once the junction temperature cools down by a thermal shutdown hysteresis ( $\Delta \mathrm{TsD}$ ), the IC will resume normal operation with a complete soft-start.

Note that the over-temperature protection is intended to protect the device during momentary overload conditions. The protection is activated outside of the absolute maximum range of operation as a secondary fail-safe and therefore should not be relied upon operationally. Continuous operation above the specified absolute maximum operating junction temperature may impair the reliability of the device or permanently damage the device.

## Output Discharge

The RT6264A/B features a discharge function that releases the output power under conditions in which the EN pin goes low, during UVP and OTP. The output discharge resistance is typically $100 \Omega$.
Absolute Maximum Ratings (Note 1)

- Supply Input Voltage, VIN ..... -0.3 V to 20 V
- Enable Voltage, EN ..... -0.3 V to 20 V
- Switch Voltage, SW -0.3 V to 20.3 V
< 100ns ..... -5 V to 25 V
- BOOT Voltage , BOOT ..... -0.3 V to 26 V
- BOOT to SW, Vboot - Vsw ..... -0.3 V to 6 V
- Feedback Voltage, FB ..... -0.3 V to 6 V
- Power Dissipation, PD @ $\mathrm{T}_{\mathrm{A}}=25^{\circ} \mathrm{C}$
TSOT-23-6 (FC) ..... 1.69 W
- Lead Temperature (Soldering, 10 sec.) ..... $260^{\circ} \mathrm{C}$
- Junction Temperature ..... $150^{\circ} \mathrm{C}$
- Storage Temperature Range ..... $-65^{\circ} \mathrm{C}$ to $150^{\circ} \mathrm{C}$
ESD Ratings
- ESD Susceptibility (Note 2)
HBM (Human Body Model) ..... 2kV
Recommended Operating Conditions ..... (Note 3)
- Supply Input Voltage ..... 4.5 V to 18 V
- Junction Temperature Range ..... $-40^{\circ} \mathrm{C}$ to $125^{\circ} \mathrm{C}$
Thermal Information (Note 4 and Note 5)

| Thermal Parameter |  | TSOT-23-6 (FC) | Unit |
| :--- | :--- | :---: | :---: |
| $\theta$ JA | Junction-to-ambient thermal resistance (JEDEC standard) | 88.7 | ${ }^{\circ} \mathrm{C} / \mathrm{W}$ |
| $\theta$ JC(Top) | Junction-to-case (top) thermal resistance | 76.9 | ${ }^{\circ} \mathrm{C} / \mathrm{W}$ |
| $\theta$ JC(Bottom) | Junction-to-case (bottom) thermal resistance | 6 | ${ }^{\circ} \mathrm{C} / \mathrm{W}$ |
| $\theta$ JA(EVB) | Junction-to-ambient thermal resistance (specific EVB) | 59 | ${ }^{\circ} \mathrm{C} / \mathrm{W}$ |
| $\Psi J C(T o p) ~$ | Junction-to-top characterization parameter | 15.3 | ${ }^{\circ} \mathrm{C} / \mathrm{W}$ |
| $\Psi J$ JB | Junction-to-board characterization parameter | 30.19 | ${ }^{\circ} \mathrm{C} / \mathrm{W}$ |

## Electrical Characteristics

( V IN $=12 \mathrm{~V}, \mathrm{~T}_{\mathrm{A}}=25^{\circ} \mathrm{C}$, unless otherwise specified)

| Parameter | Symbol | Test Conditions | Min | Typ | Max | Unit |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| Supply Voltage |  |  |  |  |  |  |
| VIN Supply Input Operating Voltage | VIN |  | 4.5 | -- | 18 | V |
| Under-Voltage Lockout Threshold | VuvLo |  | 3.7 | 4 | 4.3 | V |
| Under-Voltage Lockout Threshold Hysteresis | $\Delta$ VuvLo |  | -- | 400 | -- | mV |
| Shutdown Current | IshDN | VEN $=0 \mathrm{~V}$ | -- | 3 | 10 | $\mu \mathrm{A}$ |
| Quiescent Current | lQ | $\mathrm{V}_{\mathrm{EN}}=2 \mathrm{~V}, \mathrm{~V} \mathrm{FB}=0.8 \mathrm{~V}$ | -- | 180 | -- | $\mu \mathrm{A}$ |
| Soft-Start |  |  |  |  |  |  |
| Soft-Start Time | tss |  | -- | 1 | -- | ms |
| Enable Voltage |  |  |  |  |  |  |
| Enable Voltage Threshold | Ven_h | EN high-level input voltage | 1.16 | 1.25 | 1.34 | V |
|  | Ven_L | EN low-level input voltage | 1.01 | 1.1 | 1.19 |  |
| EN Pin Pull-Down Resistance | Ren_dn | EN pin resistance to GND, VEN $=12 \mathrm{~V}$ | 225 | 450 | 900 | k $\Omega$ |
| Feedback Voltage and Discharge Resistance |  |  |  |  |  |  |
| Feedback Threshold Voltage | VFb | VOUT $=1.05 \mathrm{~V}$ | 758 | 765 | 772 | mV |
| Feedback Input Current | IfB | $\mathrm{VFB}=0.8 \mathrm{~V}, \mathrm{TA}=25^{\circ} \mathrm{C}$ | -0.1 | 0 | 0.1 | $\mu \mathrm{A}$ |
| Internal MOSFET |  |  |  |  |  |  |
| High-Side On-Resistance | RDS(ON)_H | Vвоот $-\mathrm{VSW}=4.8 \mathrm{~V}$ | -- | 66 | -- | $\mathrm{m} \Omega$ |
| Low-Side On-Resistance | RDS(ON)_L |  | -- | 36 | -- |  |
| Current Limit |  |  |  |  |  |  |
| High-Side Switch Current Limit | ILIM_H |  | 5.4 | 6.5 | -- | A |
| Low-Side Switch Valley Current Limit | ILIM_L |  | 3.9 | 5.3 | -- |  |
| Low-Side Switch Negative Current Limit | INOC | Forced PWM mode only | -- | 2.5 | -- | A |
| Switching Frequency |  |  |  |  |  |  |
| Switching Frequency | fsw | Vout $=1.05 \mathrm{~V}$, PWM mode | -- | 650 | -- | kHz |
| On-Time Timer Control |  |  |  |  |  |  |
| Minimum On-Time | ton_min |  | -- | 60 | -- | ns |
| Minimum Off-Time | toff_MIN | $\mathrm{V}_{\mathrm{FB}}=0.5 \mathrm{~V}$ | -- | 200 | 260 | ns |
| Output Under-Voltage Protections |  |  |  |  |  |  |
| UVP Trip Threshold | Vuvp | Hiccup detect | -- | 65 | -- | \% |
| Hiccup Power On-Time | thiccup_on |  | -- | 1.8 | -- |  |
| Hiccup Power Off-Time | thiccup_OfF |  | -- | 15 | -- | ms |


| Parameter | Symbol | Test Conditions | Min | Typ | Max | Unit |  |  |
| :--- | :--- | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| Thermal Shutdown |  |  |  |  |  |  |  | TSD |
| Thermal Shutdown <br> Threshold | $\Delta$ TSD |  | -- | 155 | -- |  |  |  |
| Thermal Shutdown <br> Hysteresis |  | -- | 35 | -- | ${ }^{\circ} \mathrm{C}$ |  |  |  |

Note 1. Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions may affect device reliability.

Note 2. Devices are ESD sensitive. Handling precaution is recommended.
Note 3. The device is not guaranteed to function outside its operating conditions.
Note 4. $\theta_{\mathrm{JA}}$ and $\theta_{\mathrm{JC}}$ are measured or simulated at $\mathrm{TA}=25^{\circ} \mathrm{C}$ based on the JEDEC $51-7$ standard.
Note 5. $\theta_{\mathrm{JA}(\mathrm{EVB})}, \Psi_{\mathrm{JC}(\mathrm{TOP})}$ and $\Psi_{\mathrm{JB}}$ are measured on a high effective-thermal-conductivity four-layer test board which is in size of $70 \mathrm{~mm} \times 50 \mathrm{~mm}$; furthermore, all layers with 1 oz . Cu. Thermal resistance/parameter values may vary depending on the PCB material, layout, and test environmental conditions.

## Typical Application Circuit



Table 1. Recommended Components Selection

| Vout (V) | RFB1 <br> (k $\Omega)$ | RFB2 <br> (k $\Omega)$ | CFF (pF) | $\mathbf{R T}(\mathbf{k} \Omega)$ | $\mathbf{L}(\mu \mathbf{H})$ | Cout $(\mu \mathbf{F})$ |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| 5.0 | 54.9 | 10 | 10 to 100 | 10 | 2.2 to 4.7 | 20 to 68 |
| 3.3 | 33.2 | 10 | 10 to 100 | 10 | 1.5 to 4.7 | 20 to 68 |
| 2.5 | 22.6 | 10 | 10 to 100 | 10 | 1.5 to 4.7 | 20 to 68 |
| 1.8 | 13.7 | 10 | 10 to 100 | 10 | 1.5 to 4.7 | 20 to 68 |
| 1.5 | 9.53 | 10 | -- | -- | 1 to 4.7 | 20 to 68 |
| 1.2 | 5.76 | 10 | -- | -- | 1 to 4.7 | 20 to 68 |
| 1.0 | 3.09 | 10 | -- | -- | 1 to 4.7 | 20 to 68 |

Note :
Considering effective capacitance de-rating which is related to biased voltage level and size, the effective capacitance of Cout should meet $18 \mu \mathrm{~F}$ as $3.3 \mathrm{~V} \leq$ Vout $\leq 5 \mathrm{~V}$ and $16 \mu \mathrm{~F}$ as VOUT $<3.3 \mathrm{~V}$
The effect of higher CFF value ( $>100 \mathrm{pF}$ ) may not be obvious; Furthermore, it probably results in worse load regulation, checking the load regulation is suggested if higher CFF is applied.

Table 2. Recommended External Components

| Component | Description | Vendor P/N |
| :---: | :--- | :--- |
| CIN | $10 \mu \mathrm{~F}, 25 \mathrm{~V}, \mathrm{X} 5 \mathrm{R}, 0805$ | GRM21BR61E106MA73 (MURATA) <br> 0805X106M250 (WALSIN) |
| CoUT | $22 \mu \mathrm{~F}, 6.3 \mathrm{~V}, \mathrm{X} 5 \mathrm{R}, 0603$ | GRM187R60J226ME15 (MURATA) <br> $0603 X 226 \mathrm{M} 6 R 3$ (WALSIN) |
|  | $2.2 \mu \mathrm{H}$ | 74437346022 (WE) <br> FDVE0630-H-2R2M (MURATA) |
|  | $4.7 \mu \mathrm{H}$ | 74437346047 (WE) <br> FDSD0630-H-4R7M (MURATA) |

## Typical Operating Characteristics

L : WE-74437346022 (DCR = 18m $\Omega$ ) for $\mathrm{V}_{\text {Out }}=1 \mathrm{~V}$ and 1.8 V .
$\mathrm{L}: \mathrm{WE}-74437346047(\mathrm{DCR}=37 \mathrm{~m} \Omega)$ for Vout $=3.3 \mathrm{~V}$ and 5 V .


Efficiency vs. Output Current



Efficiency vs. Output Current


Efficiency vs. Output Current


Output Voltage vs. Output Current



Quiescent Current vs.Temperature


Reference Voltage vs.Temperature


Output Voltage vs. Input Voltage


Shutdown Current vs.Temperature


Frequency vs. Input Voltage



EN Threshold vs. Temperature


Power On from EN


Frequency vs. Temperature


UVLO vs. Temperature


Power Off from EN






Load Transient (Half Load to Full Load)



## Short Circuit Protection




## Application Information

Richtek's component specification does not include the following information in the Application Information section.
Thereby no warranty is given regarding its validity and accuracy. Customers should take responsibility to verify their own designs and reserve suitable design margin to ensure the functional suitability of their components and systems.

The output stage of a synchronous buck converter is composed of an inductor and capacitor, which stores and delivers energy to the load, and forms a second-order low-pass filter to smooth out the switch node voltage to maintain a regulated output voltage.

## Inductor Selection

The inductor selection trade-offs among size, cost, efficiency, and transient response requirements. Generally, three key inductor parameters are specified for operation with the device: inductance value (L), inductor saturation current (ISAT), and DC resistance (DCR).

A good compromise between size and loss is to choose the peak-to-peak ripple current equals to $20 \%$ to $50 \%$ of the IC rated current. The switching frequency, input voltage, output voltage, and selected inductor ripple current determines the inductor value as follows:
$\mathrm{L}=\frac{\mathrm{VOUT} \times\left(\mathrm{V}_{\text {IN }}-\mathrm{V}_{\text {OUT }}\right)}{\mathrm{V}_{\text {IN }} \times \mathrm{f}_{\mathrm{SW}} \times \Delta \mathrm{IL}}$
Once an inductor value is chosen, the ripple current ( $\Delta \mathrm{I} \mathrm{L}$ ) is calculated to determine the required peak inductor current.
$\Delta \mathrm{IL}=\frac{\mathrm{V}_{\text {OUT }} \times\left(\mathrm{V}_{\text {IN }}-\mathrm{V}_{\text {OUT }}\right)}{\mathrm{V}_{\text {IN }} \times \mathrm{fSW}^{\prime} \times \mathrm{L}}$ and IL(PEAK) $=\operatorname{loUT}(\mathrm{MAX})+\frac{\Delta \mathrm{IL}}{2}$
IL(PEAK) should not exceed the minimum value of IC's upper current limit level. Besides, the current flowing through the inductor is the inductor ripple current plus the output current. During power up, faults, or transient load conditions, the inductor current can increase above the calculated peak inductor current level calculated above. In transient conditions, the inductor current can increase up to the switch current limit of the device. For this reason, the most conservative approach is to specify an inductor with a saturation current rating which is equal to or greater than the switch current limit rather
than the peak inductor current.
Considering the Typical Application Circuit for 1.2 V output at 4 A and an input voltage of 12 V , using an inductor ripple of 1 A ( $25 \%$ of the IC rated current), the calculated inductance value is :

$$
L=\frac{1.2 \times(12-1.2)}{12 \times 650 \mathrm{kHz} \times 1 \mathrm{~A}}=1.66 \mu \mathrm{H}
$$

For the typical application, a standard inductance value of $1.5 \mu \mathrm{H}$ can be selected.
$\Delta \mathrm{L}=\frac{1.2 \times(12-1.2)}{12 \times 650 \mathrm{kHz} \times 1.5 \mu \mathrm{H}}=1.1 \mathrm{~A}(28 \%$ of the IC rated current $)$
and $\mathrm{I}_{\mathrm{L}(\mathrm{PEAK})}=4 \mathrm{~A}+\frac{1.1 \mathrm{~A}}{2}=4.55 \mathrm{~A}$

For the $1.5 \mu \mathrm{H}$ value, the inductor's saturation and thermal rating should exceed at least 4.55A. For more conservative, the rating for inductor saturation current must be equal to or greater than switch current limit of the device rather than the inductor peak current.
For EMI sensitive application, choosing shielding type inductor is preferred.

## Input Capacitor Selection

Input capacitance, CIN, is needed to filter the pulsating current at the drain of the high-side power MOSFET. CIN should be sized to do this without causing a large variation in input voltage. The waveform of CIN ripple voltage and ripple current are shown in Figure 1. The peak-to-peak voltage ripple on input capacitor can be estimated as the equation below :
$\Delta \mathrm{V}_{\mathrm{CIN}}=\mathrm{D} \times$ IOUT $\times\left(\frac{1-\mathrm{D}}{\mathrm{C}_{\mathrm{IN}} \times \mathrm{f}_{S W}}\right)+$ louT $\times \mathrm{ESR}$
where
$\mathrm{D}=\frac{\mathrm{VOUT}}{\mathrm{V}_{\text {IN }} \times \eta}$
For ceramic capacitors, the equivalent series
resistance (ESR) is very low, the ripple which is caused by ESR can be ignored, and the minimum input capacitance can be estimated as the equation below :

CIN_MIN $=$ lOUT_MAX $\times \frac{D(1-D)}{\Delta V_{\text {CIN_MAX }} \times f \text { fW }}$
where $\Delta \mathrm{V}_{\text {CIN_MAX }} \leq 200 \mathrm{mV}$


Figure 1. Cin Ripple Voltage and Ripple Current In addition, the input capacitor needs to have a very low ESR and must be rated to handle the worst-case RMS input current of :

IRMS $\cong$ louT_MAX $\times \frac{\mathrm{V}_{\text {OUT }}}{\mathrm{VIN}_{\text {IN }}} \times \sqrt{\frac{\mathrm{VIN}_{\text {IN }}}{\text { VOUT }}-1}$
It is common to use the worse IRMS $\cong \mathrm{IOUT} / 2$ at $\mathrm{VIN}=$ 2 Vout for design. Note that ripple current ratings from capacitor manufacturers are often based on only 2000 hours of life which makes it advisable to further de-rate the capacitor, or choose a capacitor rated at a higher temperature than required.

Several capacitors may also be paralleled to meet size, height and thermal requirements in the design. For low input voltage applications, sufficient bulk input capacitance is needed to minimize transient effects during output load changes.

Ceramic capacitors are ideal for switching regulator applications because of its small size, robustness, and very low ESR. However, care must be taken when these capacitors are used at the input. A ceramic input capacitor combined with trace or cable inductance forms a high quality (under damped) tank circuit. If the RT6264A/B circuit is plugged into a live supply, the input voltage can ring to twice its nominal value, possibly exceeding the device's rating. This situation is easily avoided by placing the low ESR ceramic input
capacitor in parallel with a bulk capacitor with higher ESR to damp the voltage ringing.
The input capacitor should be placed as close as possible to the VIN pins, with a low inductance connection to the GND of the IC. In addition to a larger bulk capacitor, a small ceramic capacitors of $0.1 \mu \mathrm{~F}$ should be placed close to the VIN and GND pin. This capacitor should be 0402 or 0603 in size.

## Output Capacitor Selection

The RT6264A/B are optimized for ceramic output capacitors and best performance will be obtained using them. The total output capacitance value is usually determined by the desired output voltage ripple level and transient response requirements for sag (undershoot on load apply) and soar (overshoot on load release).

## Output Ripple

The output voltage ripple at the switching frequency is a function of the inductor current ripple going through the output capacitor's impedance. To derive the output voltage ripple, the output capacitor with Capacitance (COUT) and its equivalent series resistance (RESR) must be taken into consideration. The output peak-to-peak ripple voltage (VRIPPLE) caused by the inductor current ripple ( $\Delta \mathrm{IL}$ ) is characterized by two components, which are ESR ripple (VRIPPLE(ESR)) and capacitive ripple (VRIPPLE(C)) and can be expressed as below :
$\mathrm{V}_{\text {RIPPLE }}=\mathrm{V}_{\text {RIPPLE }}(E S R)+\mathrm{V}_{\text {RIPPLE }}(\mathrm{C})$
$\mathrm{V}_{\text {RIPPLE(ESR }}=\Delta \mathrm{IL} \times \mathrm{R}_{\mathrm{ESR}}$
$\operatorname{V}_{\text {RIPPLE }}(\mathrm{C})=\frac{\Delta \mathrm{L}_{\mathrm{L}}}{8 \times \text { CoUT } \times \mathrm{fSW}}$
As ceramic capacitors are used, both parameters should be estimated due to the extremely low ESR and relatively small capacitance. Refer to the RT6264A/B's typical application circuit of 1.2 V application, the actual inductor current ripple $(\Delta \mathrm{IL})$ is 1.1 A , and the output capacitors are $2 \times 22 \mu \mathrm{~F}$ (Murata ceramic capacitor : GRM219R60J226ME47), VRIPPLE can be obtained as below.

The ripple caused by ESR ( $2 \mathrm{~m} \Omega$ ) can be calculated as :
$\mathrm{V}_{\mathrm{RIPPLE}(\mathrm{ESR})}=1.1 \mathrm{~A} \times 2 \mathrm{~m} \Omega=2.2 \mathrm{mV}$

Considering the capacitance derating, the effective capacitance is approximately $18 \mu \mathrm{~F}$ as the output voltage is 1.2 V , and another parameter is :
$\mathrm{V}_{\text {RIPPLE }(\mathrm{C})}=\frac{1.1 \mathrm{~A}}{8 \times 2 \times 18 \mu \mathrm{~F} \times 650 \mathrm{kHz}}=5.9 \mathrm{mV}$
$V_{\text {RIPPLE }}=2.2 \mathrm{mV}+5.9 \mathrm{mV}=8.1 \mathrm{mV}$

## Output Transient Undershoot and Overshoot

In addition to voltage ripple at the switching frequency, the output capacitor and its ESR also affect the voltage sag (undershoot) and soar (overshoot) when the load steps up and down abruptly. The ACOT ${ }^{\circledR}$ transient response is very quick and output transients are usually small. The following section shows how to calculate the worst-case voltage swings in response to very fast load steps.

Both undershoot voltage and overshoot voltage consist of two factors : the voltage steps caused by the output capacitor's ESR, and the voltage sag and soar due to the finite output capacitance and the inductor current slew rate. Use the following formulas to check if the ESR is low enough (typically not a problem with ceramic capacitors) and the output capacitance is large enough to prevent excessive sag and soar on very fast load step edges, with the chosen inductor value.

The amplitude of the ESR step up or down is a function of the load step and the ESR of the output capacitor :

VESR_STEP = $\Delta$ lout $\times$ Resr
The amplitude of the capacitive sag is a function of the load step, the output capacitor value, the inductor value, the input-to-output voltage differential, and the maximum duty cycle. The maximum duty cycle during a fast transient is a function of the on-time and the minimum off-time since the $A C O T{ }^{\circledR}$ control scheme will ramp the current using on-times spaced apart with minimum off-times, which is as fast as allowed. Calculate the approximate on-time (neglecting parasites) and maximum duty cycle for a given input and output voltage as :

$$
\text { toN }=\frac{V_{\text {OUT }}}{V_{\text {IN }} \times \text { fsW }} \text { and DMAX }=\frac{\text { tON }}{\text { tON }+ \text { tOFF_MIN }}
$$

The real on-time will slightly extend due to the voltage drop which is related to output current; however, this on-time compensation can be neglected. Besides, the
minimum on-time is 60 ns , typ. If the calculated on-time is smaller than minimum on-time, it and Vout will both be clamped. Calculate the output voltage sag as:

$$
\mathrm{V}_{\mathrm{SAG}}=\frac{\mathrm{L} \times(\Delta \mathrm{IOUT})^{2}}{2 \times \operatorname{CoUT} \times\left(\mathrm{VIN}(\mathrm{MIN}) \times \mathrm{D}_{\mathrm{MAX}}-\mathrm{V}_{\mathrm{OUT}}\right)}
$$

The amplitude of the capacitive soar is a function of the load step, the output capacitor value, the inductor value and the output voltage :

$$
\mathrm{V}_{\text {SOAR }}=\frac{\mathrm{L} \times(\Delta \mathrm{lOUT})^{2}}{2 \times \text { COUT } \times \text { VOUT }}
$$

Because some modern digital loads can exhibit nearly instantaneous load changes, the amplitude of the ESR should be taken into consideration while calculating the VSAG \& VSOAR.

## Output Voltage Setting

Set the desired output voltage using a resistive divider from the output to ground with the midpoint connected to FB, as shown in Figure 2. The output voltage is set according to the following equation :
Vout $=0.765 \mathrm{~V} \times(1+$ RFB1 $/$ RFB2 $)$


Figure 2. Output Voltage Setting
Place the FB resistors within 5 mm of the FB pin. Choose RFB2 between $10 \mathrm{k} \Omega$ and $100 \mathrm{k} \Omega$ to minimize power consumption without excessive noise pick-up and calculate RFB1 as follows :
$R_{\text {FB1 }}=\frac{R_{\text {FB2 }} \times\left(V_{\text {OUT }}-V_{\text {REF }}\right)}{V_{\text {REF }}}$
For output voltage accuracy, use divider resistors with $1 \%$ or better tolerance.

## Feed-Forward Capacitor Selection (Cff)

The RT6264A/B is optimized for low duty-cycle applications and the control loop is stable with low ESR ceramic output capacitors. In higher duty-cycle applications (higher output voltages or lower input
voltages), the internal ripple signal will increase in amplitude. Before the $\mathrm{ACOT}^{\circledR}$ control loop can react to an output voltage fluctuation, the voltage change on the feedback signal must exceed the internal ripple amplitude. Because of the large internal ripple in this condition, the response may become slower and under-damped. This situation will result in ringing waveform at output terminal. In case of high output voltage application, the phenomenon described above is more visible because of large attenuation in feedback network. As shown in Figure 3, adding a feedforward capacitor (CFF) across the upper feedback resistor is recommended. This increases the damping of the control system.


Figure 3. Feedback Loop with Feedforward Capacitor Loop stability can be checked by viewing the load transient response. A load step with a speed that exceeds the converter bandwidth must be applied. For ACOT ${ }^{\circledR}$, loop bandwidth can be in the order of 100 to 200 kHz , so a load step with 500 ns maximum rising time ( $\mathrm{d} / / \mathrm{dt} \approx 2 \mathrm{~A} / \mu \mathrm{s}$ ) ensures the excitation frequency is sufficient. It is important that the converter operates in PWM mode, outside the light load efficiency range, and below any current limit threshold. A load transient from $30 \%$ to $60 \%$ of maximum load is reasonable which is shown in Figure 4.


Figure 4. Example of Measuring the Converter BW by Fast Load Transient

Cff can be calculated basing on below equation :

$$
\mathrm{C}_{\mathrm{FF}}=\frac{1}{2 \pi \times \mathrm{BW}} \sqrt{\frac{1}{\mathrm{R}_{\mathrm{FB} 1}} \times\left(\frac{1}{R_{F B 1}}+\frac{1}{\mathrm{R}_{F B 2}}\right)}
$$

Figure 5. shows the transient performance with and without feedfoward capacitor.
Note that, after defining the CFF please also check the load regulation, because feedforward capacitor might inject an offset voltage into Vout to cause Vout inaccuracy. If the output voltage is over spec caused by calculated CFF, please decrease the value of feedforward capacitor CFF or place a series resistor of RT to FB pin.


Figure 5. Load Transient Response With and Without Feedforward Capacitor

## Enable Operation

The RT6264A/B is enabled when the VIN pin voltage rises above VuVLO while the EN pin voltage exceeds VEN_H. The RT6264A/B is disabled when the VIN pin voltage falls below VuVLo - $\Delta$ VUVLo or when the EN pin voltage is below VEN_L. An internal pull-down resistor REN_DN, which is connected form EN to GND, ensures that the chip still stays in shutdown even if EN pin is floated.

For automatic start-up, the EN pin, with high-voltage rating, can be connected to the input supply Vin directly as shown in Figure 6.

The built-in hysteresis band makes the EN pin useful for simple delay and timing circuits. The EN pin can be externally connected to VIN by adding a resistor REN and a capacitor CEN, as shown in Figure 7, to have an additional delay. The time delay can be calculated by the equation below with the EN's internal threshold, at
which switching operation begins.
$\mathrm{C}_{\mathrm{EN}}=\frac{t}{R_{\mathrm{th}} \times \ln \frac{V_{\text {th }}}{\mathrm{V}_{\mathrm{th}}-\mathrm{V}_{\text {EN_H }}}}$
, where
$R_{t h}=R_{E N} / / R_{\text {En_d }}$
$\mathrm{V}_{\text {th }}=\mathrm{V}_{\mathrm{IN}} \times \frac{R_{\text {EN_DN }}}{R_{\text {EN_DN }}+\mathrm{R}_{\mathrm{EN}}}$
An external MOSFET can be used for logic control which is shown in Figure 8. In this case, REN is connected between VIN and the EN pin. The MOSFET Q1 will be under logic control to pull down the EN pin.
If the device is desired to be shut down by EN pin before VIN falls below the UVLO threshold, a resistive divider (REN1 and REN2) can be used to externally set the input under-voltage lockout threshold as shown in Figure 9. For a given REN1, REN2 can be found by the equation below for the desired VIN stop voltage.
VIN_STOP $\times \frac{R_{E N 2} / / R_{E N} \text { DN }}{R_{E N 1}+R_{E N 2} / / R_{E N \_D N}}<V_{E N \_L}$
After Ren1 and Ren2 are defined, the input voltage VIn_start is obtained from
$V_{E N \_H} \times \frac{R_{E N 1}+R_{E N 2} / / R_{E N} \text { dN }}{R_{\text {EN2 }} / / R_{E N} \text { DN }}=V_{\text {IN_START }}$


Figure 6. Automatic Start-Up Setting


Figure 7. External Timing Control


Figure 8. Digital Enable Control Circuit


Figure 9. Resistor Divider for Lockout Threshold Setting
If VIN shuts down faster than Vout and Vout is larger than 3.7 V , buck converter becomes boost converter and generates negative current. To prevent these condition, EN should be shut down before VIN falls below Vout. Therefore, the resistor divider for lockout threshold is recommended.

## Bootstrap Driver Supply

The bootstrap capacitor (Своот) between the BOOT pin and the SW pin is used to create a voltage rail above the applied input voltage, VIN. Specifically, the bootstrap capacitor is charged through an internal diode to a voltage equal to approximately PVCC each time the low-side switch is turned on. The charge on this capacitor is then used to supply the required current during the remainder of the switching cycle. For most applications, a $0.1 \mu \mathrm{~F}, 0603$ ceramic capacitor with X 5 R is recommended and the capacitor should have a 6.3 V or higher voltage rating.

## External Bootstrap Diode (Optional)

A bootstrap capacitor of $0.1 \mu \mathrm{~F}$ low-ESR ceramic capacitor is connected between the BOOT and SW pins to supply the high-side gate driver. It is recommended to add an external bootstrap diode between an external 5 V voltage supply and the BOOT pin as shown in Figure 10
to improve efficiency when the input voltage is below 5.5 V . The bootstrap diode can be a low-cost one, such as 1 N 4148 or BAT54. The external 5V can be a fixed 5V voltage supply from the system, or a 5 V output voltage generated by the RT6264A/B. Note that the BOOT voltage VBOOT must be lower than 5.5 V .


Figure 10. External Bootstrap Diode

## External Bootstrap Resistor (Optional)

The gate driver of an internal power MOSFET, utilized as a high-side switch, is optimized for turning on the switch. The gate driver is not only fast enough for reducing switching power loss, but also slow enough for minimizing EMI. The EMI issue is worse when the switch is turned on rapidly due to the induced high di/dt noises. When the high-side switch is turned off, the discharging time on SW node is relatively slow because there's the presence of dead time, both high-side and low-side MOSFETs are turned off in this interval. In some cases, it is desirable to reduce EMI further, even at the expense of some additional power dissipation. The turn-on rate of the high-side switch can be slowed by placing a small bootstrap resistor RBOOT between the BOOT pin and the external bootstrap capacitor as shown in Figure 11. The recommended range for the Rвоот is several ohms to 47 ohms, and it could be 0402 or 0603 in size.

This will slow down the rates of the high-side switch turn on and the rise of Vsw. In order to improve EMI performance and enhancement of the internal MOSFET switch, the recommended application circuit is shown in Figure 12, which includes an external bootstrap diode for charging the bootstrap capacitor and a bootstrap resistor Rвоот placed between the BOOT pin and the capacitor/diode connection.


Figure 11. External Bootstrap Resistor at the BOOT Pin


Figure12. External Bootstrap Diode and Resistor at the BOOT Pin

## Thermal Considerations

In many applications, the RT6264A/B does not generate much heat due to its high efficiency and low thermal resistance of its TSOT-23-6 (FC) package. However, in applications which the RT6264A/B runs at a high ambient temperature and high input voltage, the generated heat may exceed the maximum junction temperature of the part.
The RT6264A/B includes an over-temperature protection (OTP) circuitry to prevent overheating due to excessive power dissipation. If the junction temperature reaches approximately $155^{\circ} \mathrm{C}$, the RT6264A/B stops switching the power MOSFETs until the temperature is cooled down by $35^{\circ} \mathrm{C}$.
Note that the over-temperature protection is intended to protect the device during momentary overload conditions. The protection is activated outside of the absolute maximum range of operation as a secondary fail-safe and therefore should not be relied upon operationally. Continuous operation above the specified absolute maximum operating junction temperature may impair device reliability or permanently damage the device.
The maximum power dissipation can be calculated by the following formula :

$$
P_{D(M A X)}=\left(T_{J(M A X)}-T_{A}\right) / \theta_{J A(E F F E C T I V E)}
$$

where $T_{J}(\operatorname{MAX})$ is the maximum allowed junction temperature of the die. For recommended operating condition specifications, the maximum junction temperature is $125^{\circ} \mathrm{C} . \mathrm{T}_{\mathrm{A}}$ is the ambient operating temperature, and $\theta_{J A(E F F E C T I V E) ~ i s ~ t h e ~ s y s t e m-l e v e l ~}^{\text {a }}$ junction to ambient thermal resistance. It can be estimated from thermal modeling or measurements in the system.

The thermal resistance of the device strongly depends on the surrounding PCB layout and can be improved by providing a heat sink of surrounding copper ground. The addition of backside copper with thermal vias, stiffeners, and other enhancements can also help reduce thermal resistance.

As an example, considering the RT6264A is used in application where $\mathrm{VIN}=12 \mathrm{~V}$, $\mathrm{IOUT}=4 \mathrm{~A}, \mathrm{fSW}=650 \mathrm{kHz}$, VOUT $=1 \mathrm{~V}$. The efficiency at $1 \mathrm{~V}, 4 \mathrm{~A}$ is $71.9 \%$ by using WE-74437346022 $(2.2 \mu \mathrm{H}, 18 \mathrm{~m} \Omega \mathrm{DCR})$ as the inductor and measured at room temperature. The core loss can be obtained from its website, and it's 20.4 mW . In this case, the power dissipation of the RT6264A is

$$
P_{\mathrm{D}, \mathrm{RT}}=\frac{1-\eta}{\eta} \times \mathrm{P}_{\mathrm{OUT}}-\left(\mathrm{I}_{\mathrm{O}}^{2} \times \mathrm{DCR}+\mathrm{P}_{\mathrm{CORE}}\right)=1.255 \mathrm{~W}
$$

Considering the system-level $\theta_{\mathrm{JA}(E F F E C T I V E)}$ is $64.9^{\circ} \mathrm{C} / \mathrm{W}$ (other heat sources are also considered), the junction temperature of the regulator operating in a $25^{\circ} \mathrm{C}$ ambient temperature is approximately :

$$
\mathrm{T}_{J}=1.19 \mathrm{~W} \times 64.9^{\circ} \mathrm{C} / \mathrm{W}+25^{\circ} \mathrm{C}=106.45^{\circ} \mathrm{C}
$$

Figure 13 shows the RT6264A/B RDS(ON) versus different junction temperatures. If the application requires a higher ambient temperature, the device power dissipation and the junction temperature of the device need to be recalculated based on a higher RDS(ON) since it increases with temperature.
Using $40^{\circ} \mathrm{C}$ ambient temperature as an example. Due to the variation of junction temperature is dominated by the ambient temperature, the $\mathrm{T} \cdot \mathrm{J}$ at $40^{\circ} \mathrm{C}$ ambient temperature can be pre-estimated as
$\mathrm{T}_{j}^{\prime}=106.45^{\circ} \mathrm{C}+\left(40^{\circ} \mathrm{C}-25^{\circ} \mathrm{C}\right)=121.45^{\circ} \mathrm{C}$
According to Figure 13, the increasing $\operatorname{RdS}(\mathrm{ON})$ can be found as
$\Delta \mathrm{R}_{\mathrm{DS}(\mathrm{ON}) \_\mathrm{H}}=90.6 \mathrm{~m} \Omega\left(\right.$ at $\left.121.45^{\circ} \mathrm{C}\right)-86.9 \mathrm{~m} \Omega\left(106.45^{\circ} \mathrm{C}\right)=3.7 \mathrm{~m} \Omega$ $\Delta R_{D S(O N) \_}=44.8 \mathrm{~m} \Omega\left(\right.$ at $\left.121.45^{\circ} \mathrm{C}\right)-43.2 \mathrm{~m} \Omega\left(106.45^{\circ} \mathrm{C}\right)=1.6 \mathrm{~m} \Omega$ The external power dissipation caused by the increasing RDS(ON) at higher temperature can be calculated as
$\Delta \mathrm{P}_{\mathrm{D}, \mathrm{RDS}(\mathrm{ON})}=(4 \mathrm{~A})^{2} \times \frac{1}{12} \times 3.7 \mathrm{~m} \Omega+(4 \mathrm{~A})^{2} \times\left(1-\frac{1}{12}\right)$ $\times 1.6 \mathrm{~m} \Omega=0.028 \mathrm{~W}$

As a result, the new power dissipation is 1.283 W due to the variation of RDS(ON). Therefore, the estimated new junction temperature is

$$
\mathrm{T}_{j^{\prime}}=1.283 \mathrm{~W} \times 64.9^{\circ} \mathrm{C} / \mathrm{W}+40^{\circ} \mathrm{C}=123.3^{\circ} \mathrm{C}
$$

If the application requires a higher ambient temperature and may exceed the recommended maximum junction temperature of $125^{\circ} \mathrm{C}$, care should be taken to reduce the temperature rise of the part by using a heat sink or air flow.


Figure 13. RT6264A/B RDS(ON) vs. Temperature

## Layout Considerations

Follow the PCB layout guidelines below for optimal performance of the device.

- Keep the high-current paths short, especially at the ground terminals. This practice is essential for stable and jitter-free operation. The high current path comprising of input capacitor, high-side FET, inductor, and the output capacitor should be as short as possible. This practice is essential for high efficiency.
- Place the input MLCC capacitors as close to the VIN and GND pins as possible. The major MLCC capacitors should be placed on the same layer as the RT6264A/B.
- SW node is with high frequency voltage swing and should be kept at small area. Keep analog components away from the SW node to prevent stray capacitive noise pickup.
- Connect feedback network behind the output capacitors. Place the feedback components next to the FB pin.
- For better thermal performance, design a wide and thick plane for GND pin or add a lot of vias to GND plane. An example of PCB layout guide is shown in Figure 14.


Figure 14. Layout Guide

## Outline Dimension



| Symbol | Dimensions In Millimeters |  | Dimensions In Inches |  |  |  |  |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  | Min. | Max. | Min. | Max. |  |  |  |
| A | 0.700 | 1.000 | 0.028 | 0.039 |  |  |  |
| A1 | 0.000 | 0.100 | 0.000 | 0.004 |  |  |  |
| B | 1.397 | 1.803 | 0.055 | 0.071 |  |  |  |
| b | 0.300 | 0.559 | 0.012 | 0.022 |  |  |  |
| C | 2.591 | 3.000 | 0.102 | 0.118 |  |  |  |
| D | 2.692 | 3.099 | 0.106 | 0.122 |  |  |  |
| e | 0.950 |  |  |  |  |  | 0.037 |
| H | 0.080 | 0.254 | 0.003 | 0.010 |  |  |  |
| L | 0.300 | 0.610 | 0.012 | 0.024 |  |  |  |

TSOT-23-6 (FC) Surface Mount Package

Footprint Information


| Package | Number of | Footprint Dimension (mm) |  |  |  |  |  | Tolerance |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  | Pin | P1 | A | B | C | D | M |  |
| TSOT-26/TSOT-26(FC)/SOT-26/SOT-26(COL) | 6 | 0.95 | 3.60 | 1.60 | 1.00 | 0.70 | 2.60 | $\pm 0.10$ |

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Datasheet Revision History

| Version | Date | Description | Item |
| :--- | :--- | :--- | :--- |
| 03 | $2024 / 1 / 12$ | Modify | General Description on P1 <br> Ordering Information on P2 <br> Functional Block Diagram on P3 <br> Operation on P6 <br> Application Information on P16 |

